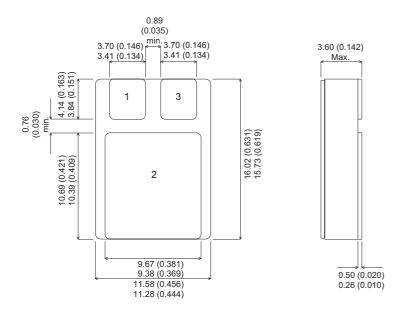




MECHANICAL DATA

Dimensions in mm (inches)



SMD 1 (TO-276AB)

Pad 1 - Gate Pad 3 - Source Pad 2 – Drain

P-CHANNEL **POWER MOSFET** FOR HI-REL **APPLICATIONS**

V_{DSS} -100V I_{D(cont)} -12A R_{DS(on)} 0.3Ω

FEATURES

- HERMETICALLY SEALED
- SIMPLE DRIVE REQUIREMENTS
- LIGHTWEIGHT
- SCREENING OPTIONS AVAILABLE
- ALL LEADS ISOLATED FROM CASE

(also available as IRF9530SMD with Gate and Source reversed)

ABSOLUTE MAXIMUM RATINGS (T_{case} = 25°C unless otherwise stated)

$\overline{BV_{DS}}$	Drain – Source BreakdownVoltage	-100V		
V_{GS}	Gate – Source Voltage	±20V		
I_D	Continuous Drain Current @ T _{case} = 25°C	-12A		
I_D	Continuous Drain Current @ T _{case} = 100°C	-8A		
I_{DM}	Pulsed Drain Current	-48A		
P_{D}	Power Dissipation @ T _{case} = 25°C	75W		
	Linear Derating Factor	0.6W/°C		
T_J , T_stg	Operating and Storage Temperature Range	−55 to +175°C		
$R_{ heta JC}$	Thermal Resistance Junction to Case	1.7°C/W max.		

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Issue 1





ELECTRICAL CHARACTERISTICS ($T_C = 25$ °C unless otherwise stated)

	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
	STATIC ELECTRICAL RATINGS	•	•			
BV _{DSS}	Drain – Source Breakdown Voltage	$V_{GS} = 0$ $I_{D} = -250 \mu A$	-100			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Temperature Coefficient of Breakdown Voltage	Reference to 25°C I _D = -1mA	4	-0.1		V/°C
R _{DS(on)}	Static Drain – Source On–State Resistance*	$V_{GS} = -10V$ $I_D = -7A$			0.30	Ω
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$ $I_D = -250\mu A$	-2		-4	V
9 _{fs}	Forward Transconductance*	$V_{DS} \ge -50V$ $I_{DS} = -7A$	3.7			S(Ω)
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -100V			-100	μΑ
	$(V_{GS} = 0)$	$V_{DS} = -80V$ $T_{J} = 150^{\circ}C$			-500	
I _{GSS}	Forward Gate – Source Leakage	V _{GS} = -20V			-100	nA
I _{GSS}	Reverse Gate – Source Leakage	V _{GS} = 20V			100	
	DYNAMIC CHARACTERISTICS	•	•			
C _{iss}	Input Capacitance	$V_{GS} = 0$		860		pF
C _{oss}	Output Capacitance	V _{DS} = -25V		340		
C _{rss}	Reverse Transfer Capacitance	f = 1MHz		93		
Q_g	Total Gate Charge	V _{GS} = -10V			38	
Q _{gs}	Gate - Source Charge	I _D = -12A			6.8	nC ns
Q _{gd}	Gate - Drain ("Miller") Charge	$V_{DS} = 0.8BV_{DSS}$			21	
t _{d(on)}	Turn-On Delay Time	V _{DD} = -50V		12		
t _r	Rise Time	I _D = -12A		52		
t _{d(off)}	Turn-Off Delay Time	$R_G = 12\Omega$		31		
t _f	Fall Time	$R_D = 3.9\Omega$		39		
	SOURCE - DRAIN DIODE CHARAC	TERISTICS				
I _S	Continuous Source Current				-12	А
I_{SM}	Pulse Source Current				-48	
V_{SD}	Diode Forward Voltage*	$I_S = -12A$ $V_{GS} = 0_V$,		-6.3	V
t _{rr}	Reverse Recovery Time	$I_F = -12A$ $V_{DD} \le -50$	V	120	240	ns
Q _{rr}	Reverse Recovery Charge	d _i / d _t ≤ -100A/μs		0.46	0.92	μС

Notes

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^{*} Pulse Test: Pulse Width $\leq 300 \mu s$, $\delta \leq 2\%$